

Search Notes

Application/Control No.

10/776,672

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

PAVEL ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
216	59	2/16/2006	BT
216	60	2/16/2006	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update search using databases in EAST	2/16/2006	BT